



IMPEDANCE ANALYZER IM7583, IM7585

Component Measuring Instruments

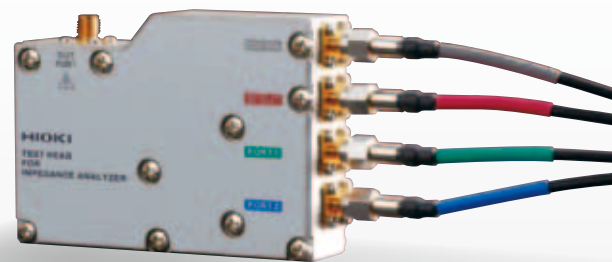


IM7583

Measurement frequency
1 to 600
MHz MHz

IM7585

Measurement frequency
1 to 1.3
MHz GHz



Super Fast

Maximum speed : **0.5ms**
(Analog measurement time)

Super Stable

Measured value variability : **0.07%**
(When measuring at 1GHz with the IM7585)

High-speed, highly stable measurement to boost your production volume

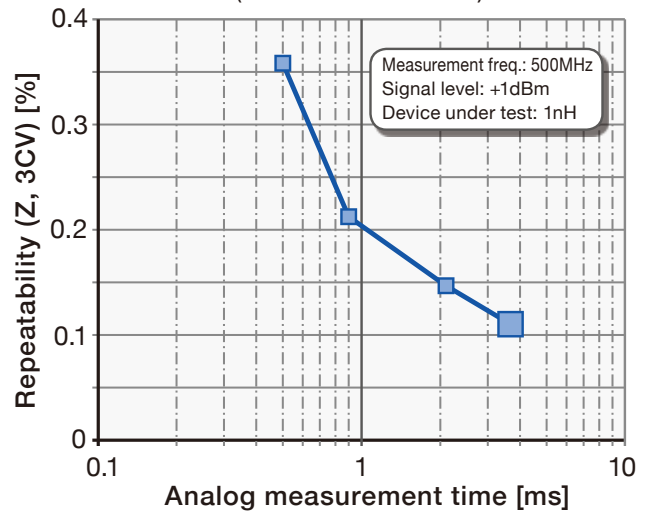
Ideal for common mode filter and chip inductor production lines

IMPEDANCE ANALYZER IM7583



Measurement frequency
1MHz to 600MHz

Repeatability and analog measurement time
(Data shown for reference)



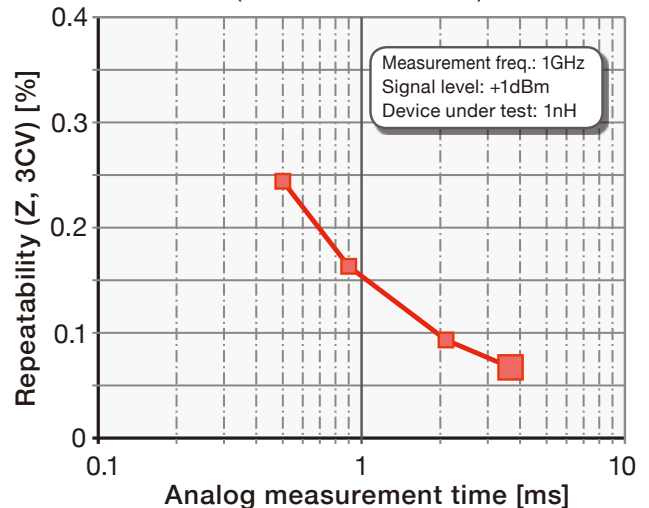
Perfect for R&D and production of ferrite chip beads and chip inductors

IMPEDANCE ANALYZER IM7585



Measurement frequency
1MHz to 1.3GHz

Repeatability and analog measurement time
(Data shown for reference)



Measurement capabilities suited to a variety of production lines



For single-frequency pass/fail judgments:
[LCR mode]



For multiple-frequency pass/fail judgments:
[Analyzer mode : Spot judgment]



For pass/fail judgments based on frequency characteristics:
[Analyzer mode : Peak judgment]



For combined LCR + analyzer testing:
[Continuous measurement mode]

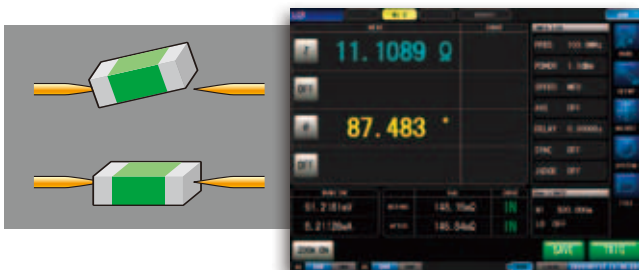
Functions, Features and Small Form Factor to Enable Efficient and Intelligent Measurement and Analysis

R&D applications

- Measure frequency characteristics and level characteristics
- Five-model equivalent circuit analysis
- Measured value search function

Contact check function (DCR measurement, Hi-Z reject)

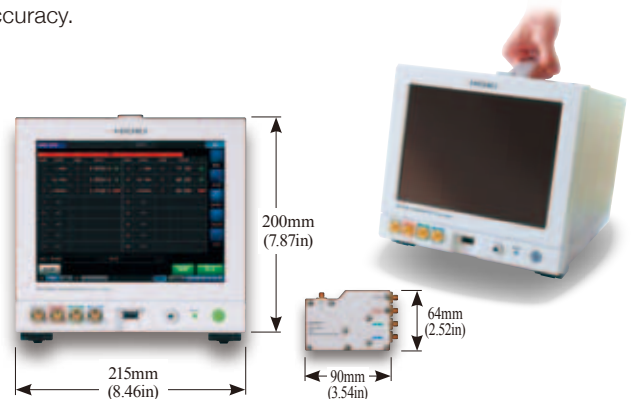
Perform contact checks using DCR measurement on components such as inductors, ferrite cores, and common mode filters. The IM7585 can also perform contact checks using Hi-Z reject functionality for components such as capacitors. Both of these capabilities can be combined with a chatter detection check to deliver highly reliable measurements.



Half-rack dimensions and intuitive operability enhances productivity

The compact design lets you stack two units side-by-side to mount into a full-rack space so that you can use two Impedance Analyzers simultaneously to further streamline testing and increase production yield. Customize the brightness, color and viewing size of the large color display in order to accommodate the needs of your workspace, and use the convenient touch screen to achieve maximum work efficiency.

The bundled test head is also compact and unobtrusive, letting you set it as close to the device under test as possible in order to minimize noise and other adverse effects that can impact accuracy.



Basic Specifications

(Accuracy guaranteed for: 1 year. Post-adjustment accuracy guaranteed for: 1 year.)

Measurement frequency	Frequency range : IM7583 1 MHz to 600 MHz IM7585 1 MHz to 1.3 GHz Measurement resolution : 100 kHz
Measurement parameters	Z, Y, θ , Rs, Rp, X, G, B, Cs, Cp, Ls, Lp, D, Q
Measurement level	-40.0 dBm to +1.0 dBm (4 mV to 502 mVrms)
Measurement time	As fast as 0.5 ms (Analog measurement time)
Measurement range	100 m Ω to 5 k Ω
Basic accuracy	Z : $\pm 0.65\%$ rdg. θ : $\pm 0.38^\circ$
Power supply and maximum rated power	AC 100 V to 240 V (50 Hz / 60 Hz), 70VA
Dimensions and mass	Approx. 215W \times 200H \times 348D mm (8.46W \times 7.87H \times 13.7D in), Approx. 8.0 kg (282.3 oz)
Accessories	Power cord \times 1, Instruction manual \times 1, Impedance analyzer application disc \times 1

Measurement mode	LCR mode: Measurement using a single set of conditions Analyzer mode: Sweep measurement and equivalent circuit analysis Continuous measurement mode: Continuous measurement using previously saved conditions
LCR mode	Bin measurement: 10 categories for 4 measurement parameters Comparator measurement: Hi, IN and Lo judgments for 4 parameters
Analyzer mode	Frequency/level sweep measurement (801 points) Time interval measurement
Continuous measurement mode	LCR mode: 30 conditions, Analyzer mode: 16 conditions
Contact check	DCR measurement, HI-Z reject, Waveform judgment (chatter detection)
Interfaces	USB, LAN, GP-IB (optional), RS-232C (optional) *These interfaces support programming commands used with the HIOKI Model 3535 LCR HiTester. Handler, USB memory

Instrument



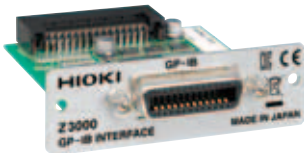
- IMPEDANCE ANALYZER IM7583-01 (Order code: IM7583-01)
Composition: Main unit, Test Head, Connection cable (1m)
- IMPEDANCE ANALYZER IM7583-02 (Order code: IM7583-02)
Composition: Main unit, Test Head, Connection cable (2m)
- IMPEDANCE ANALYZER IM7585-01 (Order code: IM7585-01)
Composition: Main unit, Test Head, Connection cable (1m)
- IMPEDANCE ANALYZER IM7585-02 (Order code: IM7585-02)
Composition: Main unit, Test Head, Connection cable (2m)

Test fixtures or probes are not included with the main unit.
A dedicated test fixture is required. For more information, please contact your HIOKI distributor.

Options

Interfaces

*Any interlink-compatible cross-cable can be used as the RS-232C CABLE.



GP-IB INTERFACE Z3000



GP-IB CONNECTION CABLE 9151-02
Cable length: 2 m (6.56 ft)



RS-232C INTERFACE Z3001



RS-232C CABLE 9637
Cable length: 1.8 m (5.91ft)

Test fixtures and associated options: Available soon

- TEST FIXTURE STAND IM9200
- ADAPTER IM9906 (3.5 mm to 7 mm)
- SMD TEST FIXTURE IM9201

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HIOKI

HIOKI E. E. CORPORATION

HEADQUARTERS

81 Koizumi, Ueda, Nagano, 386-1192, Japan
TEL +81-268-28-0562 FAX +81-268-28-0568
<http://www.hioki.com> / E-mail: os-com@hioki.co.jp

HIOKI USA CORPORATION

TEL +1-609-409-9109 FAX +1-609-409-9108
<http://www.hiokiusa.com> / E-mail: hioki@hiokiusa.com

HIOKI (Shanghai) SALES & TRADING CO., LTD.
TEL +86-21-63910090 FAX +86-21-63910360
<http://www.hioki.cn> / E-mail: info@hioki.com.cn

DISTRIBUTED BY

HIOKI INDIA PRIVATE LIMITED
TEL +91-124-6590210
E-mail: hioki@hioki.in

HIOKI SINGAPORE PTE. LTD.
TEL +65-6634-7677 FAX +65-6634-7477
E-mail: info-sg@hioki.com.sg

HIOKI KOREA CO., LTD.
TEL +82-2-2183-8847 FAX +82-2-2183-3360
E-mail: info-kr@hioki.co.jp